Series -



ES52C1 A 10 V -12.800M Nominal Frequency 12.800MHz RoHS Compliant (Pb-free) 5mm x 7mm Ceramic SMD 3.3Vdc Clipped Sinewave TC(VC)XO

Operating Temperature Range 0°C to +50°C

Frequency Stability ±1.0ppm Maximum

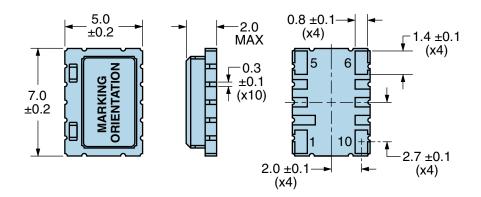
Control Voltage 1.5Vdc ±1.0Vdc

ELECTRICAL SPECIFICATIONS		
Nominal Frequency	12.800MHz	
Frequency Stability vs. Frequency Tolerance	±1.0ppm Maximum (Measured at 25°C ±2°C, Vdd=3.3Vdc, Vc=1.5Vdc)	
Frequency Stability	±1.0ppm Maximum	
Frequency Stability vs. Input Voltage	±0.2ppm Maximum (Vdd ±5%)	
Frequency Stability vs. Aging	±1ppm/Year Maximum (at 25°C)	
Frequency Stability vs. Load	±0.2ppm Maximum (±1kOhm//±1pF)	
Operating Temperature Range	0°C to +50°C	
Supply Voltage	3.3Vdc ±5%	
Input Current	1.5mA Maximum	
Output Voltage	0.8Vp-p Clipped Sinewave Minimum	
Load Drive Capability	10kOhms//10pF	
Output Logic Type	Clipped Sinewave	
Control Voltage	1.5Vdc ±1.0Vdc	
Frequency Deviation	±8ppm Minimum	
Linearity	10% Maximum	
Transfer Function	Positive Transfer Characteristic	
Modulation Bandwidth	3kHz Minimum (Measured at -3dB with a Control Voltage of 1.5Vdc)	
Input Impedance	100kOhms Minimum	
Phase Noise	-80dBc/Hz at 10Hz offset, -115dBc/Hz at 100Hz offset, -135dBc/Hz at 1kHz offset, -145dBc/Hz at 10kHz offset, -145dBc/Hz at 100kHz offset (Typical Values, at 12.800MHz)	
Start Up Time	5mSec Maximum	
Storage Temperature Range	-55°C to +125°C	

ENVIRONMENTAL & MECHANICAL SPECIFICATIONS		
Fine Leak Test	MIL-STD-883, Method 1014 Condition A	
Gross Leak Test	MIL-STD-883, Method 1014 Condition C	
Mechanical Shock	MIL-STD-202, Method 213 Condition C	
Resistance to Soldering Heat	MIL-STD-202, Method 210	
Resistance to Solvents	MIL-STD-202, Method 215	
Solderability	MIL-STD-883, Method 2003	
Temperature Cycling	MIL-STD-883, Method 1010	
Vibration	MIL-STD-883, Method 2007 Condition A	



MECHANICAL DIMENSIONS (all dimensions in millimeters)

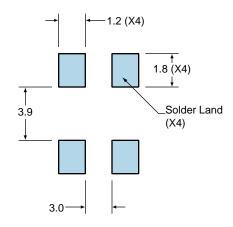


PIN	CONNECTION
1	Voltage Control
2	Do Not Connect
3	Do Not Connect
4	Do Not Connect
5	Case/Ground
6	Output
7	Do Not Connect
8	Do Not Connect
9	Do Not Connect
10	Supply Voltage

LINE	MARKING
1	E12.800 <i>E=Ecliptek</i>
2	XXYZZ XX=Ecliptek Manufacturing Code Y=Last Digit of the Year ZZ=Week of the Year

Suggested Solder Pad Layout

All Dimensions in Millimeters

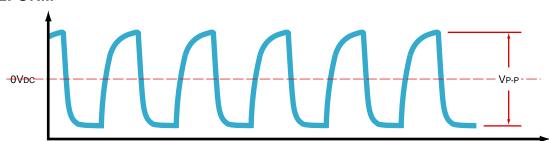


All Tolerances are ±0.1

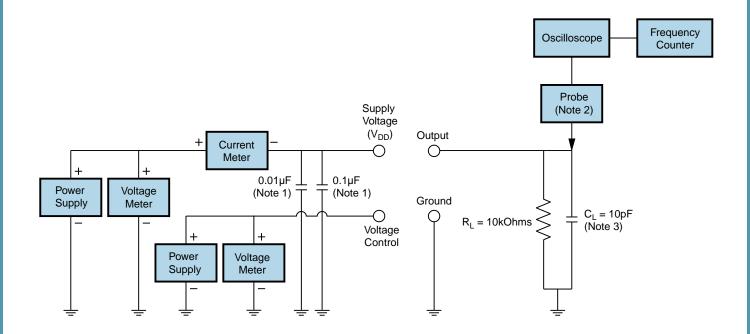


OUTPUT WAVEFORM

CLOCK OUTPUT



Test Circuit for Voltage Control Option



- Note 1: An external $0.1\mu F$ low frequency tantalum bypass capacitor in parallel with a $0.01\mu F$ high frequency ceramic bypass capacitor close to the package ground and V_{DD} pin is required.
- Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.
- Note 3: Capacitance value C_L includes sum of all probe and fixture capacitance.



Recommended Solder Reflow Methods



Low Temperature Infrared/Convection 220°C

T _S MAX to T _L (Ramp-up Rate)	5°C/second Maximum
Preheat	
- Temperature Minimum (T _s MIN)	N/A
- Temperature Typical (T _s TYP)	150°C
- Temperature Maximum (T _s MAX)	N/A
- Time (t _s MIN)	60 - 120 Seconds
Ramp-up Rate (T _L to T _P)	5°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	150°C
- Time (t∟)	200 Seconds Maximum
Peak Temperature (T _P)	220°C Maximum
Target Peak Temperature (T _P Target)	220°C Maximum 1 Time / 215°C Maximum 1 Time
Time within 5°C of actual peak (tp)	15 seconds Maximum 1 Time / 80 seconds Maximum 1 Time
Ramp-down Rate	5°C/second Maximum
Time 25°C to Peak Temperature (t)	N/A
Moisture Sensitivity Level	Level 1

Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum.

High Temperature Manual Soldering

260°C Maximum for 5 seconds Maximum, 2 times Maximum.